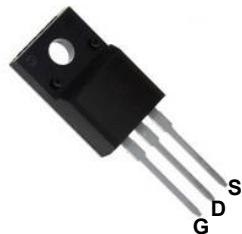
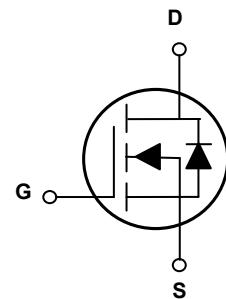


### Main Product Characteristics

$V_{(BR)DSS}$	950V
$R_{DS(ON)}$	1.2Ω (Max.)
$I_D$	5A



TO-220F



Schematic Diagram

### Features and Benefits

- Advanced MOSFET process technology
- Low drain-to-source voltage drop ( $V_{DS(on)}$ )
- Fast switching and reverse body recovery



### Description

The GSFU9504 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

### Absolute Maximum Ratings ( $T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	$V_{DSS}$	950	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	V
Drain Current-Continuous <sup>1</sup> ( $T_C=25^\circ\text{C}$ )	$I_D$	5	A
Drain Current-Continuous <sup>1</sup> ( $T_C=100^\circ\text{C}$ )		3.2	
Drain Current-Pulsed <sup>2</sup> ( $T_C=25^\circ\text{C}$ )	$I_{D,pulse}$	15	A
Continuous Diode Forward Current <sup>1</sup> ( $T_C=25^\circ\text{C}$ )	$I_S$	5	A
Diode Pulsed Current <sup>2</sup> ( $T_C=25^\circ\text{C}$ )	$I_{S,pulse}$	15	A
Power Dissipation <sup>3</sup> ( $T_C=25^\circ\text{C}$ )	$P_D$	31	W
Single Pulsed Avalanche Energy <sup>4</sup>	$E_{AS}$	160	mJ
MOSFET dv/dt Ruggedness, $V_{DS}=0-480\text{V}$	dv/dt	50	V/ns
Reverse Diode dv/dt, $V_{DS}=0-480\text{V}$ , $I_{SD} \leq I_D$	dv/dt	15	V/ns
Thermal Resistance, Junction-to-Ambient	$R_{\text{JA}}$	62.5	°C/W
Thermal Resistance, Junction-to-Case	$R_{\text{JC}}$	4	°C/W
Junction Temperature Range	$T_J$	-55 To +150	°C
Storage Temperature Range	$T_{STG}$	-55 To +150	°C

**Electrical Characteristics** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On / Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	950	-	-	V
Drain-Source Leakage Current	$I_{\text{DS}(\text{SS})}$	$V_{\text{DS}}=950\text{V}, V_{\text{GS}}=0\text{V}$	-	-	10	$\mu\text{A}$
Gate-Source Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm 30\text{V}$	-	-	$\pm 100$	nA
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=2\text{A}$	-	0.92	1.2	$\Omega$
		$V_{\text{GS}}=10\text{V}, I_{\text{D}}=2\text{A}, T_J=150^\circ\text{C}$	-	2.82	-	
Gate Resistance	$R_{\text{G}}$	F=1MHz, Open Drain	-	29.5	-	$\Omega$
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250\mu\text{A}$	2.9	-	3.9	V
<b>Dynamic and Switching Characteristics</b>						
Total Gate Charge	$Q_{\text{g}}$	$V_{\text{DS}}=400\text{V}, I_{\text{D}}=2.5\text{A}, V_{\text{GS}}=10\text{V}$	-	14.9	-	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	4.8	-	
Gate-to-Drain Charge	$Q_{\text{gd}}$		-	3.4	-	
Gate Plateau Voltage	$V_{\text{plateau}}$		-	5	-	
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DS}}=400\text{V}, R_{\text{G}}=2\Omega, V_{\text{GS}}=10\text{V}, I_{\text{D}}=2.5\text{A}$	-	30	-	nS
Rise Time	$t_{\text{r}}$		-	14	-	
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	59.6	-	
Fall Time	$t_{\text{f}}$		-	27.2	-	
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=50\text{V}, V_{\text{GS}}=0\text{V}, F=100\text{kHz}$	-	878	-	pF
Output Capacitance	$C_{\text{oss}}$		-	34	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	1.5	-	
Effective Output Capacitance, Energy Related	$C_{\text{o(er)}}$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}-400\text{V}$	-	21	-	
Effective Output Capacitance, Time Related	$C_{\text{o(tr)}}$		-	108	-	
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Peak Reverse Recovery Current	$I_{\text{rrm}}$	$V_{\text{R}}=400\text{V}, I_{\text{s}}=2.5\text{A}, \text{di/dt}=100\text{A}/\mu\text{s}$	-	15.8	-	A
Reverse Recovery Time	$T_{\text{rr}}$		-	216	-	ns
Reverse Recovery Charge	$Q_{\text{rr}}$		-	1.8	-	uc
Diode Forward Voltage	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_{\text{s}}=5\text{A}$	-	-	1.3	V

Note:

- Calculated continuous current based on maximum allowable junction temperature.
- Repetitive rating; pulse width limited by max. junction temperature.
- $P_{\text{d}}$  is based on max. junction temperature, using junction-case thermal resistance.
- $V_{\text{DD}}=100\text{V}, V_{\text{GS}}=10\text{V}, L=80\text{mH}$ , starting  $T_J=25^\circ\text{C}$ .

## Typical Electrical and Thermal Characteristic Curves

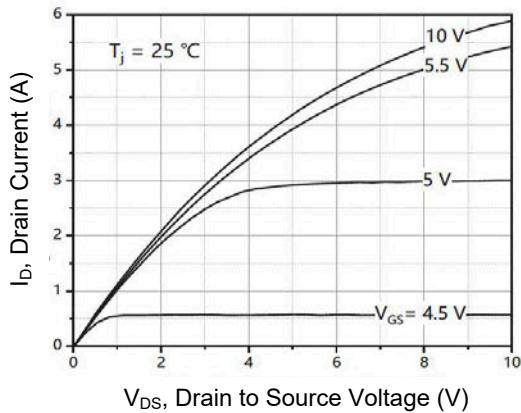


Figure 1. Output Characteristics

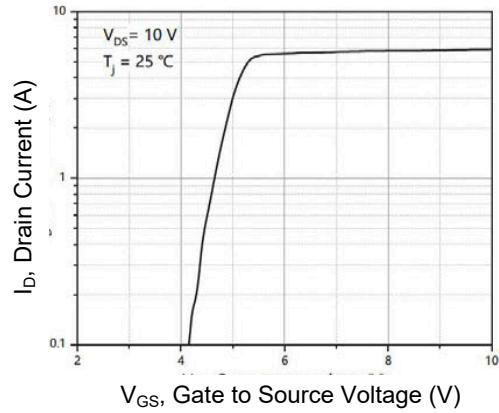


Figure 2. Transfer Characteristics

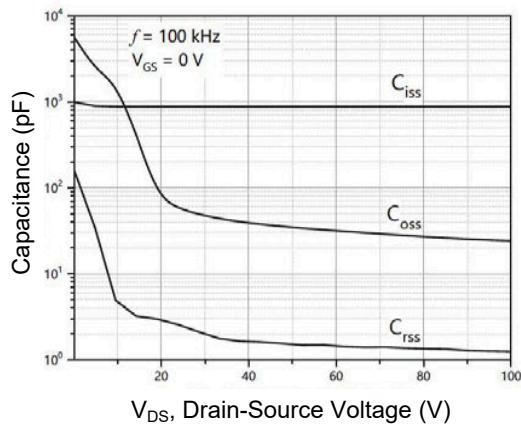


Figure 3. Capacitance Characteristics

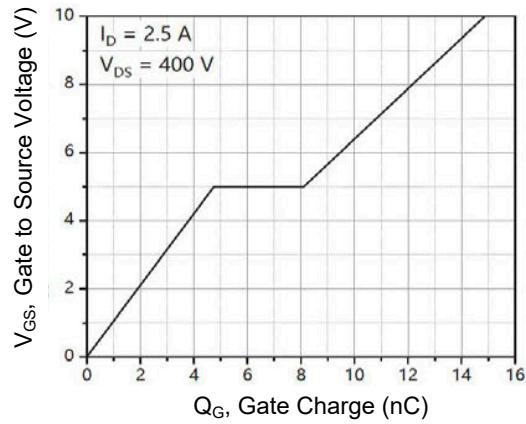


Figure 4. Gate Charge

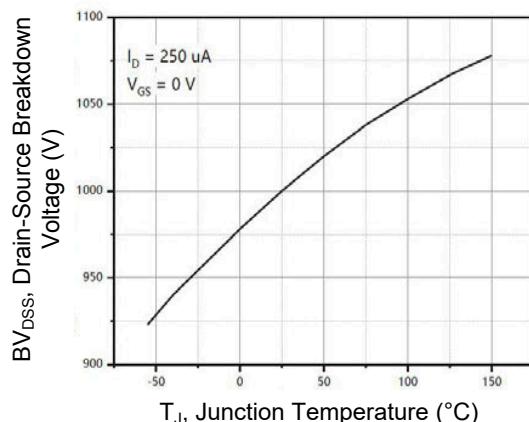


Figure 5. Drain-Source Breakdown Voltage

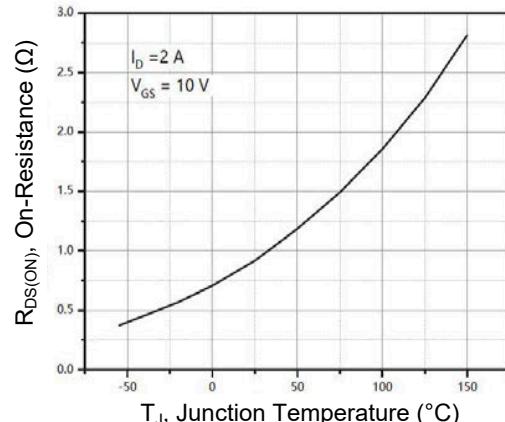


Figure 6. Drain-Source On-State Resistance

## Typical Electrical and Thermal Characteristic Curves

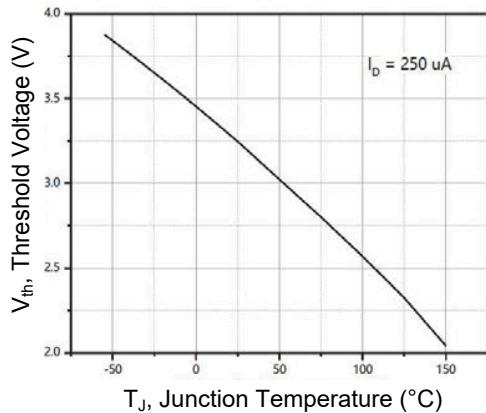


Figure 7. Threshold Voltage

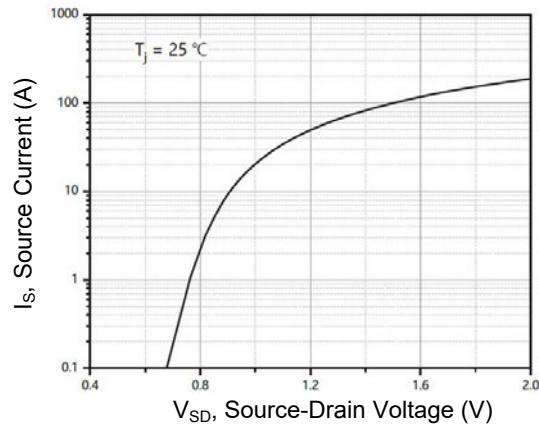


Figure 8. Forward Characteristics of Body Diode

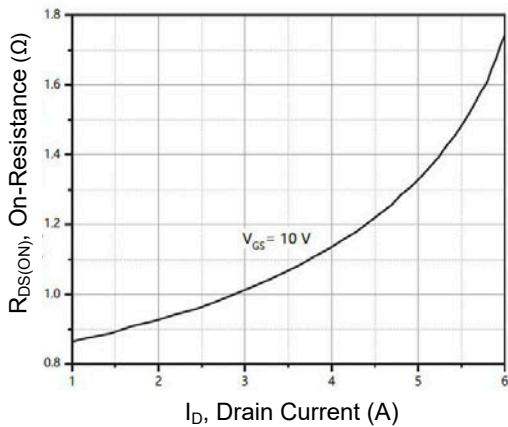


Figure 9.  $R_{DS(ON)}$  vs. Drain Current

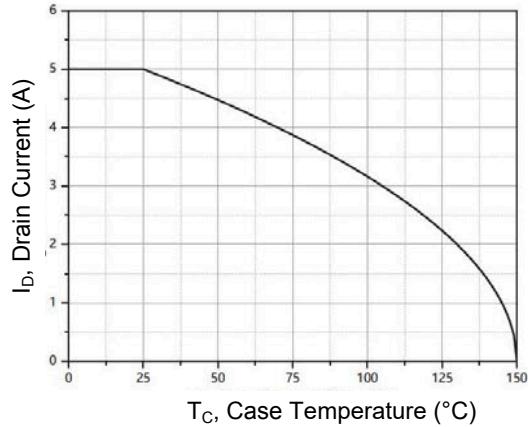


Figure 10. Drain Current

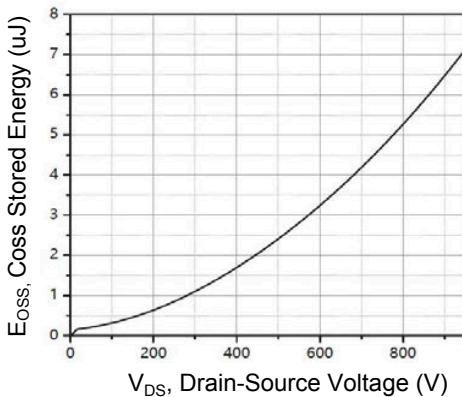


Figure 11. Typ. Coss Stored Energy

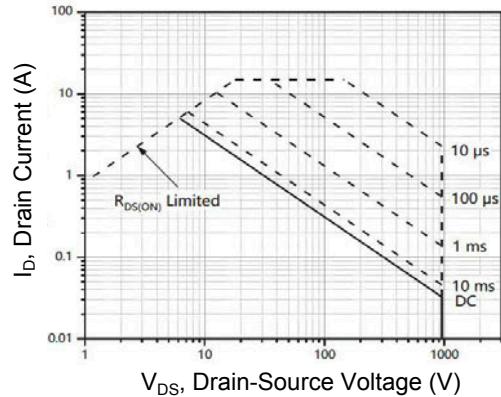


Figure 12. Safe Operation Area,  $T_c=25^\circ\text{C}$

## Typical Electrical and Thermal Characteristic Curves

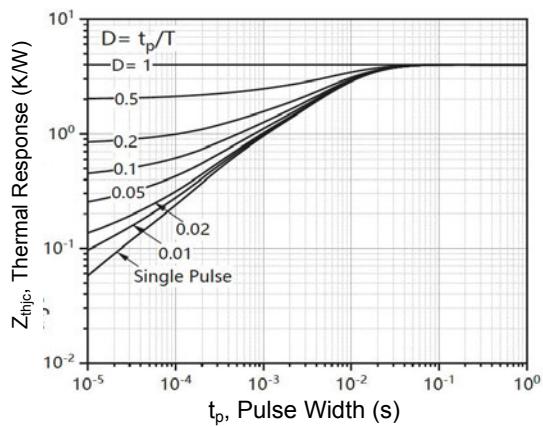
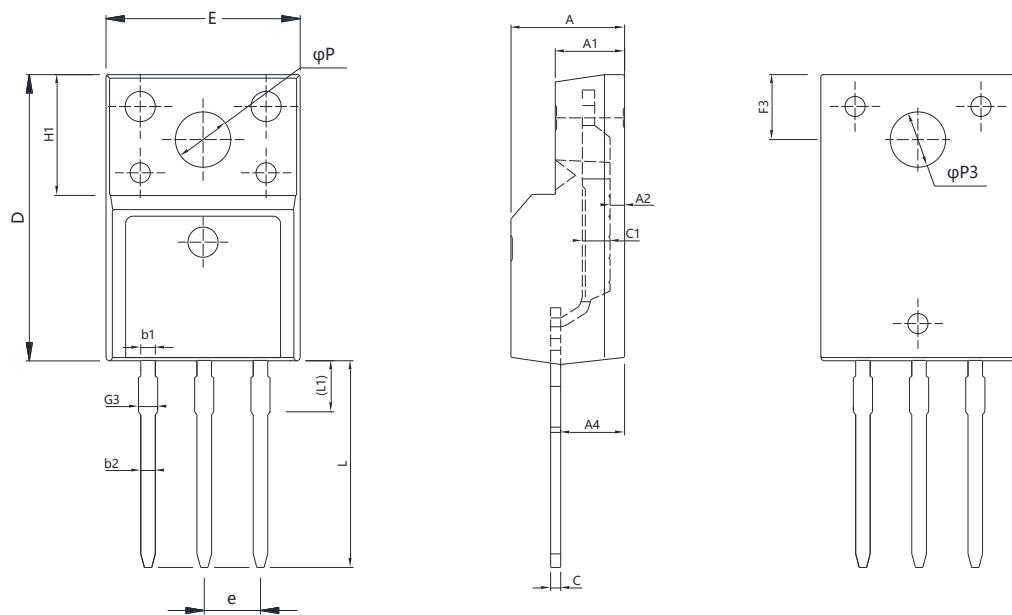


Figure 13. Max. Transient Thermal Impedance

### Package Outline Dimensions (TO-220F)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
E	9.960	10.360	0.392	0.408
A	4.500	4.900	0.177	0.193
A1	2.340	2.740	0.092	0.108
A2	0.300	0.600	0.012	0.024
A4	2.560	2.960	0.101	0.117
c	0.400	0.650	0.016	0.026
C1	1.200	1.350	0.047	0.053
D	15.570	16.170	0.613	0.637
H1	6.700 REF		0.264 REF	
e	2.540 BSC		0.100 BSC	
L	12.680	13.280	0.499	0.523
L1	2.880	3.180	0.113	0.125
θP	3.030	3.380	0.119	0.133
θP3	3.150	3.650	0.124	0.144
F3	3.150	3.450	0.124	0.136
G3	1.250	1.550	0.049	0.061
b1	1.180	1.430	0.046	0.056
b2	0.700	0.950	0.028	0.037